Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/077,545	HAYASHI, YOSHIAKI
Examiner	Art Unit
Bob Chevalier	2621

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Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED		
Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		